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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants : Yoshihiro HAMA et al.

Confirmation No.: 6387

Appl. No. : 10/804,130

Group Art Unit : 2873

Filed : March 19, 2004

Examiner : Jessica STULTZ

For : LENS UNIT FOR MULTIBEAM SCANNING DEVICE

COMMENTS ON STATEMENT OF REASONS FOR ALLOWANCE

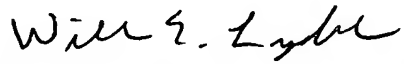
Commissioner for Patents
U.S. Patent and Trademark Office
Customer Service Window, Mail Stop Issue Fee
Randolph Building
401 Dulany Street
Alexandria, VA 22314

Sir:

In response to the Notice of Allowability, mailed by the Patent and Trademark Office on August 9, 2005 and to the Statement of Reasons for Allowance attached thereto, Applicants wish to clarify the record with respect to the basis for the patentability of claims in the present application. In this regard, while Applicants do not disagree with the Examiner's indication that certain identified features are not disclosed by the references, Applicants submit that each of the claims in the present application recite a particular combination of features, and that the basis for patentability of each of these claims is based on the totality of the particular features recited therein.

Should there be any questions, the Examiner is invited to contact the undersigned at the below-listed telephone number.

Respectfully Submitted,
Yoshihiro HAMA et al.


Bruce H. Bernstein
Reg. No. 29,027

William E. Lyddane
Reg. No. 41,568

September 27, 2005
GREENBLUM & BERNSTEIN, P.L.C.
1950 Roland Clarke Place
Reston, VA 20191
(703) 716-1191